

DESCRIPTION

The MGF4951A/MGF4952A super-low noise HEMT (High Electron Mobility Transistor) is designed for use in C to K band amplifiers.

The lead-less ceramic package assures minimum parasitic losses.

FEATURES

Low noise figure @ f=12GHz
 MGF4951A : NFmin. = 0.40dB (Typ.)
 MGF4952A : NFmin. = 0.60dB (Typ.)

High associated gain @ f=12GHz
 Gs = 12.0dB (Typ.)

APPLICATION

C to K band low noise amplifiers

QUALITY GRADE

GG

RECOMMENDED BIAS CONDITIONS

V_{DS}=2V , I_D=10mA

ORDERING INFORMATION

Tape & reel 3000pcs./reel

Outline Drawing

Fig.1

MITSUBISHI Proprietary

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KTTIC

ABSOLUTE MAXIMUM RATINGS

(Ta=25°C)

Symbol	Parameter	Ratings	Unit
V _{GDO}	Gate to drain voltage	-4	V
V _{GSO}	Gate to source voltage	-4	V
I _D	Drain current	60	mA
PT	Total power dissipation	50	mW
T _{ch}	Channel temperature	125	°C
T _{stg}	Storage temperature	-65 to +125	°C

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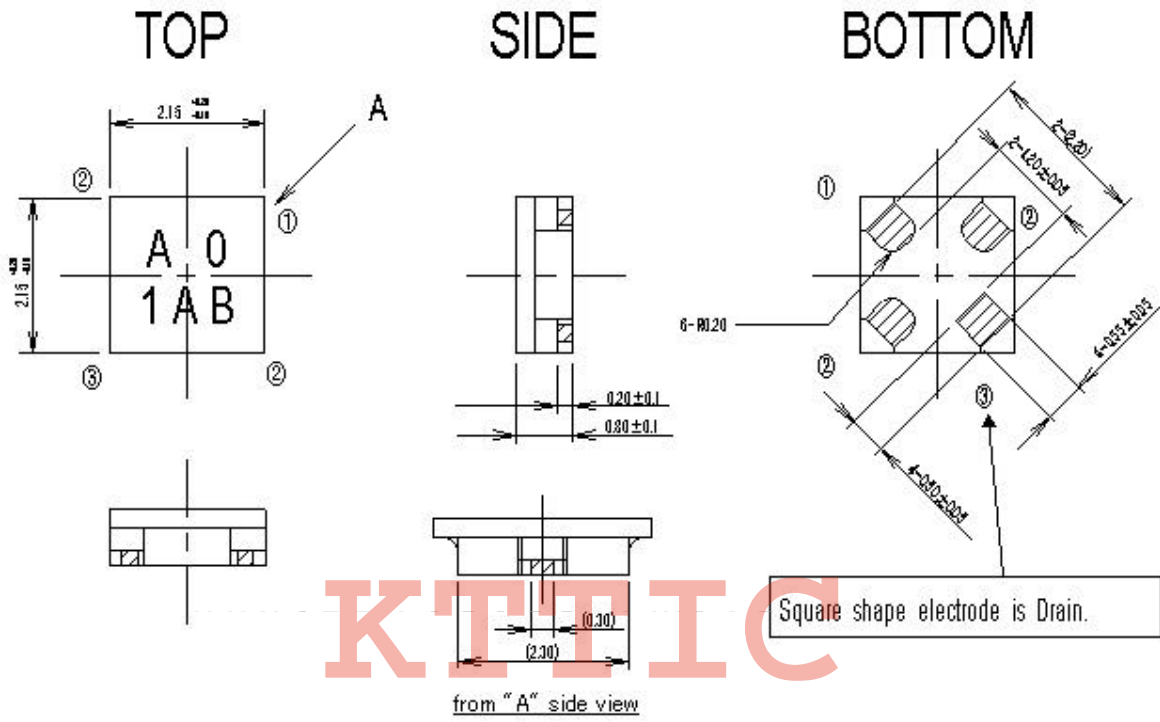
ELECTRICAL CHARACTERISTICS

(Ta=25°C)

Symbol	Parameter	Test conditions	Limits			Unit	
			MIN.	TYP.	MAX		
V _{(BR)GDO}	Gate to drain breakdown voltage	I _G =-10μA	-3	--	--	V	
I _{GSS}	Gate to source leakage current	V _{GS} =-2V, V _{DS} =0V	--	--	50	μA	
I _{DSS}	Saturated drain current	V _{GS} =0V, V _{DS} =2V	15	--	60	mA	
V _{GS(off)}	Gate to source cut-off voltage	V _{DS} =2V, I _D =500μA	-0.1	--	-1.5	V	
gm	Transconductance	V _{DS} =2V, I _D =10mA	--	70	--	mS	
Gs	Associated gain	V _{DS} =2V, I _D =10mA	11.0	12.0	--	dB	
NFmin.	Minimum noise figure	f=12GHz	MGF4951A	--	0.40	0.50	dB
			MGF4952A	--	0.60	0.80	dB

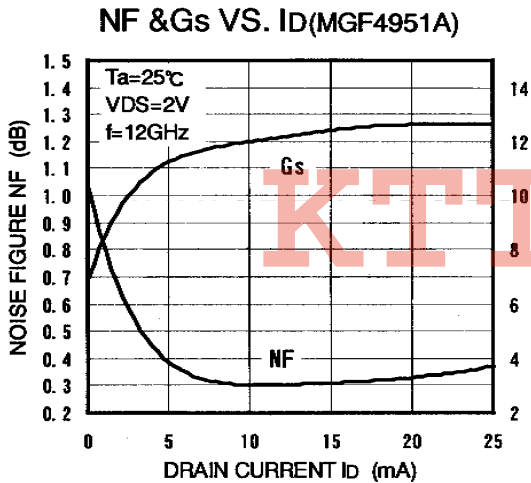
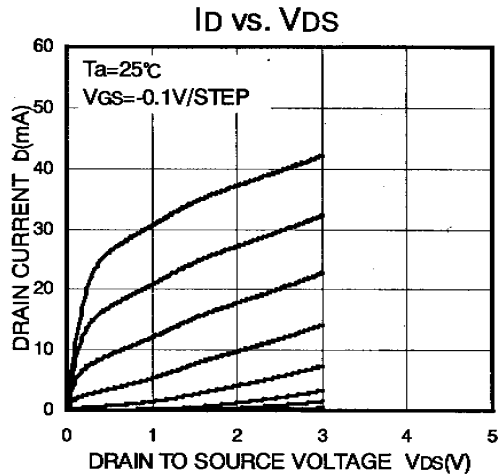
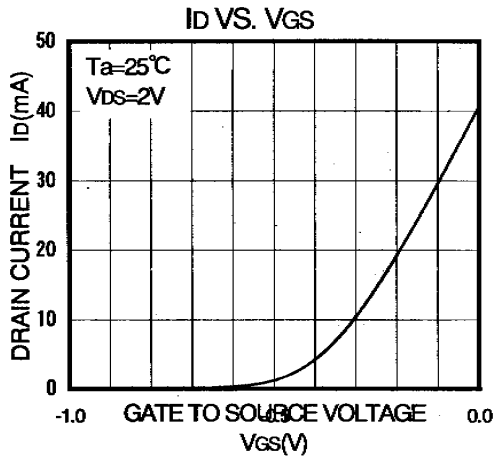
Fig.1

Unit : mm



- ① Gate
- ② Source
- ③ Drain

TYPICAL CHARACTERISTICS (Ta=25°C)



KTTIC

S PARAMETERS

(Ta=25°C, VDS=2V, ID=10mA)

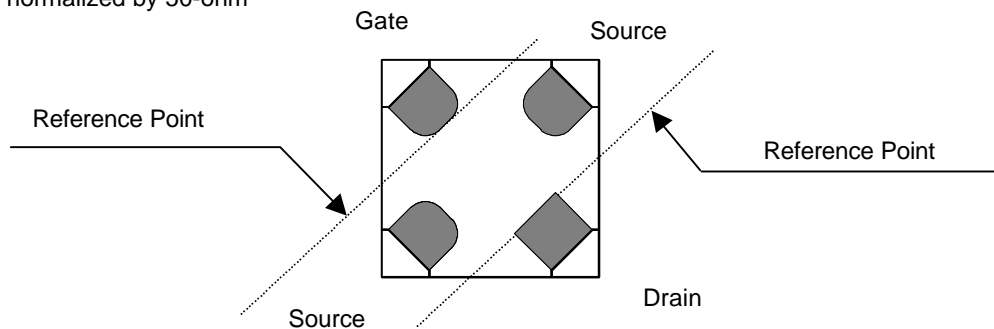
f (GHz)	S11		S21		S12		S22	
	Magn.	Angle	Magn.	Angle	Magn.	Angle	Magn.	Angle
1.0	0.978	-14.5	4.800	163.6	0.019	78.3	0.525	-13.5
2.0	0.930	-26.3	4.857	152.8	0.037	72.5	0.513	-22.5
3.0	0.884	-43.8	4.702	133.4	0.053	59.5	0.491	-37.6
4.0	0.818	-59.6	4.514	119.5	0.066	51.1	0.458	-47.5
5.0	0.768	-71.1	4.224	108.2	0.076	44.7	0.449	-54.6
6.0	0.722	-80.2	4.008	98.9	0.084	40.1	0.444	-58.7
7.0	0.681	-88.9	3.841	89.8	0.092	36.6	0.439	-61.2
8.0	0.652	-100.4	3.681	81.5	0.099	27.8	0.440	-68.2
9.0	0.627	-114.4	3.540	74.2	0.108	24.0	0.444	-70.2
10.0	0.593	-123.2	3.476	66.6	0.117	21.3	0.442	-72.3
11.0	0.542	-133.8	3.474	57.5	0.130	15.6	0.418	-76.0
12.0	0.475	-148.6	3.487	47.7	0.142	9.6	0.380	-78.3
13.0	0.406	-178.7	3.458	37.0	0.153	2.4	0.326	-82.4
14.0	0.333	147.3	3.415	25.5	0.162	-11.0	0.234	-90.5
15.0	0.298	110.1	3.309	7.5	0.172	-20.2	0.132	-83.7
16.0	0.338	81.5	3.150	-5.6	0.175	-30.0	0.068	-20.3
17.0	0.443	60.0	2.965	-20.1	0.176	-39.6	0.169	25.0
18.0	0.564	44.4	2.670	-34.2	0.171	-50.4	0.301	26.1
19.0	0.675	32.1	2.323	-48.8	0.159	-60.0	0.431	21.3
20.0	0.763	18.5	2.030	-62.6	0.146	-69.4	0.537	15.7
21.0	0.846	8.8	1.714	-74.2	0.133	-80.3	0.612	4.5
22.0	0.892	1.4	1.457	-90.8	0.119	-86.8	0.684	1.2
23.0	0.912	-4.8	1.233	-101.1	0.104	-92.2	0.749	-2.5
24.0	0.927	-9.4	1.026	-109.9	0.093	-95.3	0.796	-5.5
25.0	0.932	-14.0	0.864	-118.4	0.080	-98.0	0.843	-7.1
26.0	0.933	-17.3	0.732	-124.7	0.069	-100.6	0.881	-8.6

NOISE PARAMETERS

(Ta=25°C, VDS=2V, ID=10mA)

f (GHz)	Gamma-opt		Rn (ohm)	NF (dB)
	Magn.	Angle		
4.0	0.64	49.7	0.21	0.21
8.0	0.61	100.5	0.12	0.31
12.0	0.55	143.4	0.04	0.45
14.0	0.51	158.9	0.03	0.52
18.0	0.41	172.5	0.06	0.66

Note) Rn is normalized by 50-ohm



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